Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/810,778	TANG ET AL.	
Examiner	Art Unit	

Ahmed M. Farah

3735

SEARCHED					
Class	Subclass	Date	Examiner		
606	8,9	9/2/2006	AF		
607	88-91	9/2/2006	AF		
128	898	9/2/2006	AF		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	-				
	ce Search Printout	9/2/2006	AF		

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
Inventor Search; STIC search; and EAST search: Classification (IS&R); and Text (BRS)	9/2/2006	AF		
Searched Data Basis: USPAT; USPGPUB; EPO; JPO; DERWENT; and IBM_TDB.	9/2/2006	AF		
See the attached "Search History."	9/2/2006	AF		
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